## **Preliminary**

Notice: This is not a final specification. Some parametric limits are subject to change.

### M6MGD13VW66CWG

134,217,728-BIT (8,388,608-WORD BY 16-BIT) CMOS FLASH MEMORY & 67,108,864-BIT (4,194,304-WORD BY 16-BIT) CMOS MOBILE RAM

Stacked-CSP (Chip Scale Package)

#### **Description**

The M6MGD13VW66CWG is a Stacked Chip Scale Package (S-CSP) that contents 128M-bit Flash memory and 64M-bit Mobile RAM in a 72-pin Stacked CSP for lead free use.

128M-bit Flash memory is a 8,388,608 words, single power supply and high performance non-volatile memory fabricated by CMOS technology for the peripheral circuit and DINOR IV (Divided bit-line NOR IV) architecture for the memory cell. All memory blocks are locked and can not be programmed or erased, when F-WP# is Low. Using Software Lock Release function, program or erase operation can be executed.

64M-bit Mobile RAM is a 4,194,304 words high density RAM fabricated by CMOS technology for the peripheral circuit and DRAM cell for the memory array. The interface is compatible to an asynchronous SRAM.

The cells are automatically refreshed and the refresh control is not required for system. The device also has the partial block refresh scheme and the power down mode by writing the command.

The M6MGD13VW66CWG is suitable for a high performance cellular phone and a mobile PC that are required to be small mounting area, weight and small power dissipation.

#### **Features**

Access Time Random Access/ Page Access

Flash 70ns /25ns (Max.)

Mobile RAM 85ns /25ns (Max.)

Supply Voltage  $F/M-VCC=2.7 \sim 3.0V$ 

Ambient Temperature Ta= -40 ~ 85 degree

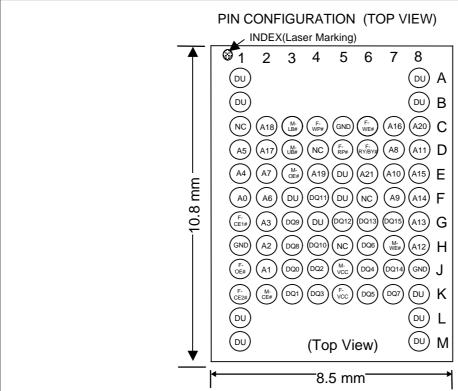
Package 72pin S-CSP,

Ball pitch 0.80mm

Outer-ball:Sn-Ag-Cu

#### **Application**

Mobile communication products



F-VCC : VCC for Flash F-RP# : Reset power down for Flash M-VCC : VCC for Mobile RAM F-WP# : Write protect for Flash **GND** : GND for Flash / Mobile RAM F-RY/BY# : Flash Memory Ready /Busy A0-A21 : Common address for Flash/Mobile RAM M-CE# : Mobile RAM chip enable DQ0-DQ15: Data I/O M-OE# : Output enable for Mobile RAM

F-CE1# : Flash chip enable 1 M-WE# : Write enable for Mobile RAM

F-CE2# : Flash chip enable 2 M-LB# : Lower byte control for Mobile RAM

F-OE# : Output enable for Flash Memory M-UB# : Upper byte control for Mobile RAM F-WE# : Write enable for Flash Memory NC : Non Connection

DU : Don't Use

## **Preliminary**

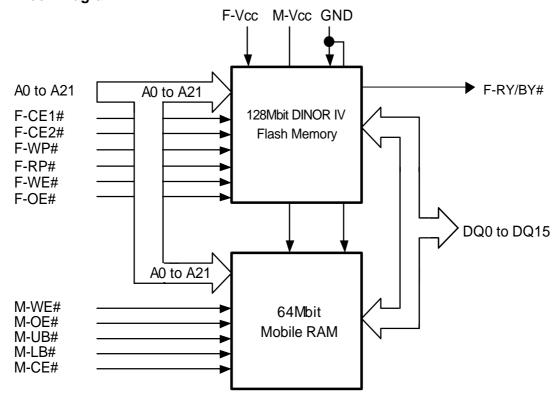
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### **MCP Block Diagram**



Note: In the 128M-bit DINOR(IV) Flash Memory lower 64Mbit is selected by F-CE1#="L" and upper 64Mbit is done by F-CE2#="L". Never select each chip at the same time.

In the data sheet there are "VCC"s which mean "F-VCC" and "M-VCC" (Each Vcc for Flash / Mobile RAM). In the Flash Memory part they mean OE# and WE# are F-OE# and F-WE#.

In the Mobile RAM part UB#, LB#, OE# and WE# are M-UB#, M-LB#, M-OE# and M-WE#, respectively.

### Capacitance

Symbol	Parameter		Conditions	Limits			Unit
Cymbol				Min.	Тур.	Max.	0.1110
CIN	Input capacitance	A21-A0, F-OE#, F-WE#, F-CE1#, F-CE2#, F-WP#, F-RP#, M-OE#, M-WE#, M-CE#, M-LB#, M-UB#	Ta=25°C, f=1MHz, Vin=Vout=0V			26	pF
COUT	Output Capacitance	DQ15-DQ0, F-RY/BY#				34	pF

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# Renesas Technology Corp.

Nippon Bldg.,6-2,Otemachi 2-chome,Chiyoda-ku,Tokyo,100-0004 Japan

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